

#### SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017 <u>& ANSI/NCSL Z540-1-1994</u>

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#### **CALIBRATION**

Valid To: March 31, 2025 Certificate Number: 2820.01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations<sup>1,8</sup>:

#### I. Dimensional

| Parameter/Equipment                                | Range         | CMC <sup>2, 5</sup> (±) | Comments                                    |
|--|---------------|-------------------------|---|
| Bore Gages & ID<br>Measuring Tools <sup>3</sup> –  |               |                         |   |
| 3-Point  | Up to 4 in    | $(36 + 2.3D) \mu in$    | Ring gages                                  |
| 2-Point  | Up to 12 in   | $(35 + 2.3D) \mu in$    | Gage blocks                                 |
| Countersink & Chamfer Gages <sup>3</sup>           | Up to 3.5 in  | (230 + 10D) μin         | Modified ring gages                         |
| Coordinate Measuring Machines (CMM) <sup>3</sup> – |               |                         | ASME B89.4.10360.2<br>Section 6.3.3         |
| Length Measurement Error ( $E_L$ )                 | Up to 27 in   | $(14 + 5.1L) \mu in$    | Step gage                                   |
| Enor (EL)  | Up to 127 in  | $(7.8 + 3.8L) \mu in$   | Gage blocks                                 |
|  | Up to 240 in  | $(6.1 + 1.2L) \mu in$   | Laser system                                |
| Repeatability (R <sub>0</sub> )                    | (10 to 50) mm | 27 μin                  | ASME B89.4.10360.2<br>Section 6.1.1; sphere |

(A2LA Cert. No. 2820.01) 03/27/2023

| Parameter/Equipment                            | Range               | CMC <sup>2, 5</sup> (±)       | Comments                                  |
|--|---------------------|-------------------------------|---|
| Spherical CMM (Laser<br>Tracker) <sup>3</sup>  | Up to 600 in        | 600 µin                       | Reference length bar                      |
| Laser Interferometer<br>Length Dependent Error | Up to 40 in         | 0.43 parts in 10 <sup>6</sup> | ASME B89.1.8 Sec 4<br>XD1 reference laser |
| Articulated Arm CMM <sup>3</sup> –             |                     |                               |   |
| Effective Dia Perf Test                        |                     | 55 μin                        | Sphere                                    |
| Single Point<br>Articulation Test              |                     | 90 μin                        | Trihedral socket                          |
| Volumetric Perf Test                           | Up to 144 in radius | $(170 + 0.2L) \mu in$         | Gage block ref. length                    |
| CNC, Machine Tools <sup>3</sup> –              |                     |                               |   |
| Repeatability @ 2<br>Sigma                     |                     | 18 μin                        | Laser per ASME B5.54<br>Sec. 7.3          |
| Linear Displacement<br>Accuracy                | Up to 260 ft        | $(83 + 1.7L) \mu in$          | Laser per ASME B5.54<br>Sec. 7.3          |
| Volumetric Performance<br>(By Body Diagonals)  |                     |                               |   |
| Bi-Directional System<br>Deviation             | Up to 260 ft        | 85 μin                        | Laser per ASME B5.54<br>Sec. 7.7          |
| Reversal Deviation                             | Up to 260 ft        | 90 μin                        | Laser per ASME B5.54<br>Sec. 7.7          |
| Bi-Directional<br>Repeatability                | Up to 260 ft        | 80 μin                        | Laser per ASME B5.54<br>Sec. 7.3          |

| Parameter/Equipment                        | Range                                   | CMC <sup>2, 5</sup> (±)                                       | Comments                        |
|--|---|---|---------------------------------|
| Gage Blocks                                | Up to 0.1 in (0.1 to 4) in (4 to 20) in | 4 μin<br>(2 + 1.4 <i>L</i> ) μin<br>(4.3 + 1.4 <i>L</i> ) μin | Master gage blocks & amplifier  |
| Micrometers <sup>3</sup> –                 |   |   |                                 |
| Linearity                                  | Up to 42 in                             | $(38 + 2.7L) \mu in$  | Gage blocks                     |
| Parallelism                                | Up to 42 in                             | $(31 + 0.25L) \mu in$   |                                 |
| Micrometer Standards &<br>Length Artifacts | Up to 41 in                             | $(12 + 2.4L) \mu in$  | Universal LMS                   |
| Depth Micrometers & Gages <sup>3</sup>     | Up to 12 in                             | $(30 + 2.5L) \mu in$  | Gage blocks                     |
| Thread Micrometers                         | Up to 6 in                              | (92 + 7.4 <i>L</i> ) μin                                      | Thread plugs                    |
| Thread Wires                               | (4.5 to 96) TPI                         | 15 μin  | Supermicrometer <sup>TM</sup> , |
| Calipers <sup>3</sup> –                    |   |   |                                 |
| Digital                                    | Up to 72 in                             | $(300 + 1.7L) \mu in$   | Gage blocks and ring            |
| Dial & Vernier                             | Up to 72 in                             | (600 + 1.9 <i>L</i> ) μin                                     | gages                           |
| Indicators, Dial & Digital <sup>3</sup>    | Up to 1 in                              | $6.5  \mu in + 0.6R$  | Gage blocks                     |
| (For Dial, Res. = 0.2<br>Least Grad.)      | (1 to 4) in                             | $(3.3 + 3L) \mu in + 0.6R$                                    |                                 |
| Height Gages <sup>3</sup>                  | Up to 40 in                             | (7.1 + 1.1 <i>L</i> ) μin                                     | Gage blocks                     |

| Parameter/Equipment                                   | Range                   | CMC <sup>2, 5</sup> (±)                       | Comments   |
|---|-------------------------|---|--|
| Plug / Pin Gages &<br>Outside Cylindrical<br>Diameter | Up to 1 in (1 to 10) in | $(6.7 + 1.8L) \mu in$<br>$(13 + 1.1L) \mu in$ | Laser scan micrometer  P&W Supermicrometer <sup>TM</sup> , gage blocks |
| Plain Rings & Inside<br>Cylindrical Diameter          | (0.04 to 11) in         | (4.6 + 0.91 <i>D</i> ) μin                    | Internal Supermicrometer <sup>TM</sup> , master gage blocks            |
| Straight Threaded Plug<br>Gages –                     |                         |   |  |
| Pitch Diameter (TPI 4.5 to 96)                        | Up to 6 in              | (76 + 6.0 <i>D</i> ) μin                      | 3-wire method  |
| Major Diameter  | Up to 5 in              | (24 + 1 <i>D</i> ) μin                        | P&W<br>Supermicrometer <sup>TM</sup> ,<br>gage blocks                  |
| Tapered Threaded Plug<br>Gages –                      |                         |   |  |
| Pitch Diameter<br>(8 to 27) TPI                       | Up to 4 in              | 92 µin  | 3-wire method, tapered sine block                                      |
| Major Diameter  | Up to 4.5 in            | 22 µin  | P&W<br>Supermicrometer <sup>TM</sup> ,<br>gage blocks                  |
| Adjustable Threaded<br>Ring Gages                     | (0.05 to 2) in diameter | (84 + 10 <i>D</i> ) μin                       | Setting plugs  |

| Parameter/Equipment                | Range                   | CMC <sup>2, 5</sup> (±)            | Comments                |
|------------------------------------|-------------------------|------------------------------------|-------------------------|
| Steel Rules <sup>3</sup> –         |                         |                                    |                         |
| Length                             | Up to 72 in             | $(590 + 1.5L) \mu in$              | Gage blocks             |
| Graduations                        |                         | $(670 + 16L) \mu in$               | Glass scale             |
| Surface Plates <sup>3</sup> –      |                         |                                    |                         |
| Flatness                           | Up to 300 in diagonal   | $(8.7 + 1.2L) \mu in$              | LDDM                    |
| Repeat Reading                     |                         | $(6.8 + 0.017L) \mu in$            | Repeat reading gage     |
| Optical Comparators <sup>3</sup> – |                         |                                    |                         |
| Linearity                          | 12 in travel            | $(12 + 3.4L) \mu in$               | Glass scale             |
| Angle                              | ±180°                   | 40 arc seconds                     |                         |
| Magnification Accuracy             | 5X to 100X              | 0.013 % of magnification           |                         |
| Measuring Tapes –                  |                         |                                    |                         |
| Length                             | Up to 330 ft            | (0.0073 + 0.000 0069 <i>L</i> ) in | Test frame              |
| Graduations                        |                         | 0.0018 in                          | Glass scale             |
| Wire Crimpers –                    |                         |                                    |                         |
| Cylindrical Crimping<br>Chamber    | (0.011 to 0.500) in     | 650 µin                            | Pin gages               |
| Shaped Crimping<br>Chamber         | Up to 1 in              | 280 μin                            | Optical comparator      |
| Crimp Height                       | Up to 1 in              | 190 μin                            | Crimp height micrometer |
| Air Gages <sup>3</sup>             | (-0.0015 to +0.0015) in | 25 μin                             | Magnification test kit  |

| Parameter/Equipment                | Range                                      | CMC <sup>2, 5</sup> (±)    | Comments                                       |
|------------------------------------|--|----------------------------|--|
| Profilometers, Ra                  | 20 μin<br>120 μin                          | 1.5 μin<br>3.1 μin         | Surface roughness<br>masters                   |
| Surface Roughness<br>Standards, Ra | (16 to 132) μin                            | (1.3 + 0.017) μin          | Comparison with surface roughness masters      |
| Radius Standard                    | (0.01 to 3) in                             | (190 + 62 <i>L</i> ) μin   | Optical comparator                             |
| Bench Micrometer –                 |  |                            |  |
| Linearity                          | Up to 1 in                                 | $(2.1 + 1.3L) \mu in$      | Gage blocks                                    |
| Anvil Parallelism                  |  | 1.4 μin                    | Ball test                                      |
| Force Error                        | (2 to 40) ozf                              | 0.13 ozf                   | Load cell                                      |
| ID Functionality                   |  | 11 μin                     | Setting rings                                  |
| Coating Thickness Meter            | Up to 80 mils                              | 0.11 % rdg + 0.023<br>mils | Coating thickness standards                    |
| Coating Thickness<br>Standard      | Up to 750 mils                             | 0.023 mils                 | Universal LMS                                  |
| Ultrasonic Thickness<br>Meter      | Up to 10 in (Ferrous) Up to 0.65 in (Alum) | 80 μin<br>100 μin          | Steel gage blocks Aluminum thickness Standards |

### II. Dimensional Testing<sup>1</sup>

| Parameter/Equipment     | Range                 | CMC <sup>2, 5</sup> (±)   | Comments                      |
|-------------------------|-----------------------|---------------------------|-------------------------------|
| Length, 1D <sup>6</sup> | Up to 10 in           | (27 + 1.2 <i>L</i> ) μin  | Supermicrometer <sup>TM</sup> |
|                         | Up to 56 in           | (590 + 2.1 <i>L</i> ) μin | CMM                           |
|                         | Up to 8.5 in          | (410 + 96 <i>L</i> ) μin  | Optical comparator            |
|                         | Up to 60 ft           | $(83 + 1.6L) \mu in$      | Laser                         |
| Length, 2D <sup>6</sup> | Up to 8" X 3"         | (370 + 120 <i>L</i> ) μin | Optical comparator            |
| Length, 3D <sup>6</sup> | Up to 47" X 32" X 24" | 700 μin                   | СММ                           |

### III. Electrical – DC/Low Frequency

| Parameter/Equipment                | Range   | CMC <sup>2, 7</sup> (±)  | Comments                               |
|------------------------------------|---|--|--|
| DC Voltage – Measure <sup>3</sup>  | Up to 100 mV<br>(0.1 to 1) V<br>(1 to 10) V<br>(10 to 100) V<br>(100 to 1000) V | $\begin{array}{c} 4.4 \; \mu V/V + 0.62 \; \mu V \\ 4.7 \; \mu V/V + 0.5 \; \mu V \\ 4.6 \; \mu V/V + 1.1 \; \mu V \\ 6.9 \; \mu V/V + 39 \; \mu V \\ 7.2 \; \mu V/V + 120 \; \mu V \end{array}$ | HP 3458A                               |
| DC Voltage – Generate <sup>3</sup> | Up to 100 mV<br>(0.1 to 1) V<br>(1 to 10) V<br>(10 to 100) V<br>(100 to 1000) V | $\begin{array}{c} 4.4 \; \mu V/V + 0.62 \; \mu V \\ 4.7 \; \mu V/V + 0.5 \; \mu V \\ 4.6 \; \mu V/V + 1.1 \; \mu V \\ 6.9 \; \mu V/V + 39 \; \mu V \\ 7.2 \; \mu V/V + 120 \; \mu V \end{array}$ | Fluke 5502A<br>monitored by<br>HP3458A |

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| Parameter/Equipment                | Range  | CMC <sup>2, 7</sup> (±)  | Comments                               |
|------------------------------------|--|--|--|
| DC Current – Measure <sup>3</sup>  | Up to 100 nA<br>100 nA to 1 μA<br>(1 to 10) μA<br>(10 to 100) μA<br>(0.1 to 1) mA<br>(1 to 10) mA<br>(10 to 100) mA<br>100 mA to 1 A | 34 μA/A + 0.047 nA<br>23 μA/A + 0.048 nA<br>23 μA/A + 0.12 nA<br>23 μA/A + 0.11 nA<br>23 μA/A + 5.9 nA<br>23 μA/A + 59 nA<br>40 μA/A + 0.63 μA<br>130 μA/A + 12 μA | HP 3458A                               |
|                                    | (1 to 20) A  | 4.7 μΑ/Α + 110 μΑ  | EL 7520 current shunt                  |
| DC Current – Generate <sup>3</sup> | Up to 100 nA<br>100 nA to 1 μA<br>(1 to 10) μA<br>(10 to 100) μA<br>(0.1 to 1) mA<br>(1 to 10) mA<br>(10 to 100) mA<br>100 mA to 1 A | 34 μA/A + 0.047 nA<br>23 μA/A + 0.048 nA<br>23 μA/A + 0.12 nA<br>23 μA/A + 0.11 nA<br>23 μA/A + 5.9 nA<br>23 μA/A + 59 nA<br>40 μA/A + 0.63 μA<br>130 μA/A + 12 μA | Fluke 5502A<br>monitored by<br>HP3458A |
|                                    | (1 to 20) A  | 4.7 μΑ/Α + 110 μΑ  | With EL 7520 current shunt             |
|                                    | (11 to 30) A<br>(30 to 110) A<br>(110 to 205) A  | 0.2 % rdg + 1.6 mA<br>0.21 % rdg + 3.9 mA<br>0.23 % rdg + 6.4 mA   | Fluke 5502A, 10<br>turn coil           |
|                                    | (55 to 150) A<br>(150 to 550) A<br>(525 to 1025) A   | 0.2 % rdg + 7.7 mA<br>0.22 % rdg + 19 mA<br>0.23 % rdg + 32 mA   | Fluke 5502A, 50<br>turn coil           |

|   | <u> </u>  | <u> </u>  | <u> </u>   |
|---|---|---|--|
| Parameter/Equipment   | Range   | CMC <sup>2, 7</sup> (±)   | Comments   |
| Resistance – Generate & Measure <sup>3</sup>  | $\begin{array}{c} (0 \text{ to } 1)  \Omega \\ (1 \text{ to } 10)  \Omega \\ (10 \text{ to } 100)  \Omega \\ 100  \Omega \text{ to } 1  k\Omega \\ (1 \text{ to } 10)  k\Omega \\ (10 \text{ to } 100)  k\Omega \\ 100  k\Omega \text{ to } 1  M\Omega \\ (1 \text{ to } 10)  M\Omega \\ (10 \text{ to } 100)  M\Omega \\ 100  M\Omega \text{ to } 1  G\Omega \\ \end{array}$ | $\begin{array}{c} 81\;\mu\Omega/\Omega + 2.7\;\mu\Omega \\ 17\;\mu\Omega/\Omega + 62\;\mu\Omega \\ 14\;\mu\Omega/\Omega + 0.58\;m\Omega \\ 12\;\mu\Omega/\Omega + 0.59\;m\Omega \\ 12\;\mu\Omega/\Omega + 5.9\;m\Omega \\ 12\;\mu\Omega/\Omega + 58\;m\Omega \\ 17\;\mu\Omega/\Omega + 2.8\;\Omega \\ 58\;\mu\Omega/\Omega + 120\;\Omega \\ 0.058\;\%\;rdg + 1.2\;k\Omega \\ 0.58\;\%\;rdg + 12\;k\Omega \\ \end{array}$  | HP34420A, HP3458A                                    |
| Capacitance – Generate  | (0.22 to 3.3) nF<br>(3.3 to 11) nF<br>(11 to 33) nF<br>(33 to 110) nF<br>(110 to 330) nF<br>(0.33 to 1.1) µF<br>(1.1 to 3.3) µF<br>(3.3 to 11) µF<br>(11 to 33) µF<br>(33 to 110) µF<br>(110 to 330) µF<br>(0.33 to 1.1) mF<br>(1.1 to 3.3) mF<br>(3.3 to 11) mF<br>(1.1 to 33) mF<br>(3.3 to 11) mF  | $\begin{array}{c} 0.58 \% \ rdg + 12 \ pF \\ 0.29 \% \ rdg + 12 \ pF \\ 0.29 \% \ rdg + 120 \ pF \\ 0.29 \% \ rdg + 120 \ pF \\ 0.29 \% \ rdg + 350 \ pF \\ 0.29 \% \ rdg + 3.5 \ nF \\ 0.29 \% \ rdg + 3.5 \ nF \\ 0.29 \% \ rdg + 12 \ nF \\ 0.29 \% \ rdg + 12 \ nF \\ 0.46 \% \ rdg + 36 \ nF \\ 0.52 \% \ rdg + 120 \ nF \\ 0.52 \% \ rdg + 350 \ nF \\ 0.52 \% \ rdg + 3.5 \ \muF \\ 0.52 \% \ rdg + 3.5 \ \muF \\ 0.52 \% \ rdg + 3.5 \ \muF \\ 0.52 \% \ rdg + 35 \ \muF \\ 0.52 \% \ rdg + 35 \ \muF \\ 0.52 \% \ rdg + 35 \ \muF \\ 0.52 \% \ rdg + 13 \ \muF \\ 0.87 \% \ rdg + 35 \ \muF \\ 1.3 \% \ rdg + 120 \ \muF \\ \end{array}$ | Fluke 5502A  |
| Electrical Calibration of<br>Thermocouple Indicators<br>& Simulators <sup>3</sup> – |   |   |  |
| Туре Е  | (-454 to 300) °F<br>(300 to 1100) °F<br>(1100 to 1832) °F   | 0.17 °F<br>0.11 °F<br>0.11 °F   | Fluke 5502A or HP<br>3245A, monitored by<br>HP 3458A |
| Туре Ј  | (-346 to -120) °F<br>(-120 to 500) °F<br>(500 to 1350) °F<br>(1350 to 2192) °F  | 0.28 °F<br>0.17 °F<br>0.13 °F<br>0.13 °F  |  |
| Туре К  | (-454 to -400) °F<br>(-400 to -120) °F<br>(-120 to 500) °F<br>(500 to 1500) °F<br>(1500 to 2500) °F   | 5.4 °F<br>0.79 °F<br>0.22 °F<br>0.18 °F<br>0.20 °F  |  |

| Parameter/Equipment  | Range  | CMC <sup>2</sup> (±)  | Comments   |
|--|--|---|--|
| Electrical Calibration of<br>Thermocouple Indicators<br>& Simulators <sup>3</sup> – (cont) |  |   |  |
| Type N   | (-400 to -300) °F<br>(-300 to -150) °F<br>(-150 to -50) °F<br>(-50 to 700) °F<br>(700 to 1500) °F<br>(1500 to 2372) °F | 1.7 °F<br>0.54 °F<br>0.35 °F<br>0.29 °F<br>0.21 °F<br>0.22 °F | Fluke 5502A or HP<br>3245A, monitored by<br>HP 3458A |
| Type R   | (-58 to 32) °F<br>(32 to 400) °F<br>(400 to 1100) °F<br>(1100 to 2200) °F  | 0.65 °F<br>0.38 °F<br>0.27 °F<br>0.24 °F                      |  |
| Type S   | (2200 to 3214) °F<br>(-58 to 32) °F<br>(32 to 400) °F<br>(400 to 1100) °F  | 0.24 °F<br>0.51 °F<br>0.33 °F<br>0.27 °F                      |  |
| Туре Т   | (1100 to 2200) °F<br>(2200 to 3214) °F   | 0.24 °F<br>0.24 °F  |  |
|  | (-400 to -300) °F<br>(-300 to 120) °F<br>(-120 to 200) °F<br>(200 to 752) °F   | 0.69 °F<br>0.34 °F<br>0.23 °F<br>0.16 °F                      |  |
| Electrical Calibration of<br>RTD Indicators &<br>Simulators <sup>3</sup> –                 |  |   |  |
| Pt 385, 100 Ω  | (-320 to 32) °F<br>(32 to 400) °F<br>(400 to 800) °F<br>(800 to 1200) °F<br>(1200 to 1562) °F                          | 0.013 °F<br>0.016 °F<br>0.02 °F<br>0.027 °F<br>0.035 °F       | HP 3458A   |
| Pt 385, 1000 Ω   | (-320 to 32) °F<br>(32 to 400) °F<br>(400 to 800) °F<br>(800 to 1200) °F<br>(1200 to 1562) °F                          | 0.009 °F<br>0.016 °F<br>0.020 °F<br>0.027 °F<br>0.033 °F      |  |

| Parameter/Range                   | Frequency   | CMC <sup>2, 7</sup> (±)   | Comments |
|-----------------------------------|---|---|----------|
| AC Voltage – Measure <sup>3</sup> |   |   |          |
| (1 to 10) mV                      | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz<br>(100 to 300) kHz<br>(0.3 to 1) MHz<br>(1 to 4) MHz<br>(4 to 8) MHz                                    | $\begin{array}{c} 0.034 \% + 3.6 \; \mu V \\ 0.023 \% + 1.4 \; \mu V \\ 0.034 \% + 1.4 \; \mu V \\ 0.011 \% + 1.9 \; \mu V \\ 0.58 \% + 1.4 \; \mu V \\ 4.6 \% + 4.2 \; \mu V \\ 4.6 \% + 7.7 \; \mu V \\ 8.1 \% + 8.8 \; \mu V \\ 23 \% + 19 \; \mu V \end{array}$                   | HP 3458A |
| (10 to 100) mV                    | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz<br>(100 to 300) kHz<br>300 kHz to 1 MHz<br>(1 to 2) MHz<br>(2 to 4) MHz<br>(4 to 8) MHz<br>(8 to 10) MHz | $83 \ \mu V/V + 4.7 \ \mu V \\ 83 \ \mu V/V + 2.4 \ \mu V \\ 0.016 \% + 2.7 \ \mu V \\ 0.035 \% + 2.4 \ \mu V \\ 0.092 \% + 2.8 \ \mu V \\ 0.35 \% + 12 \ \mu V \\ 1.2 \% + 12 \ \mu V \\ 1.7 \% + 45 \ \mu V \\ 4.6 \% + 100 \ \mu V \\ 4.6 \% + 120 \ \mu V \\ 17 \% + 440 \ \mu V$ |          |
| 100 mV to 1 V                     | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz<br>(100 to 300) kHz<br>300 kHz to 1 MHz<br>(1 to 2) MHz<br>(2 to 4) MHz<br>(4 to 8) MHz<br>(8 to 10) MHz | $82 \ \mu V/V + 47 \ \mu V$ $82 \ \mu V/V + 24 \ \mu V$ $0.016 \ \% + 26 \ \mu V$ $0.035 \ \% + 24 \ \mu V$ $0.092 \ \% + 28 \ \mu V$ $0.35 \ \% + 120 \ \mu V$ $1.2 \ \% + 120 \ \mu V$ $1.7 \ \% + 450 \ \mu V$ $4.6 \ \% + 1.1 \ mV$ $4.6 \ \% + 1.2 \ mV$ $17 \ \% + 4.4 \ mV$    |          |
| (1 to 10) V                       | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz<br>(100 to 300) kHz<br>300 kHz to 1 MHz<br>(1 to 2) MHz<br>(2 to 4) MHz<br>(4 to 8) MHz<br>(8 to 10) MHz | $83 \ \mu V/V + 0.47 \ mV$ $82 \ \mu V/V + 0.24 \ mV$ $0.016 \ \% + 0.26 \ mV$ $0.035 \ \% + 0.24 \ mV$ $0.092 \ \% + 0.28 \ mV$ $0.35 \ \% + 1.2 \ mV$ $1.2 \ \% + 1.2 \ mV$ $1.7 \ \% + 4.6 \ mV$ $4.6 \ \% + 11 \ mV$ $4.6 \ \% + 12 \ mV$ $17 \ \% + 44 \ mV$                     |          |

| Parameter/Range                          | Frequency  | CMC <sup>2, 7</sup> (±)  | Comments                                       |
|--|--|--|--|
| AC Voltage – Measure <sup>3</sup> (cont) |  |  |  |
| (10 to 100) V                            | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz<br>(100 to 300) kHz<br>300 kHz to 1 MHz | 0.023 % + 4.8 mV<br>0.023 % + 2.5 mV<br>0.023 % + 2.5 mV<br>0.04 % + 2.8 mV<br>0.14 % + 2.4 mV<br>0.46 % + 14 mV<br>1.7 % + 44 mV  | HP 3458A                                       |
| (100 to 1000) V                          | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz   | 0.046 % + 49 mV<br>0.046 % + 26 mV<br>0.07 % + 23 mV<br>0.14 % + 23 mV<br>0.35 % + 23 mV   |  |
| AC Voltage – Generate                    |  |  |  |
| (1 to 10) mV                             | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz<br>(100 to 300) kHz<br>300 kHz to 1 MHz | $\begin{array}{c} 0.034 \% + 3.6 \ \mu V \\ 0.022 \% + 1.5 \ \mu V \\ 0.033 \% + 1.5 \ \mu V \\ 0.11 \% + 1.9 \ \mu V \\ 0.58 \% + 1.5 \ \mu V \\ 4.6 \% + 4.2 \ \mu V \\ 4.6 \% + 7.7 \ \mu V \\ \end{array}$ | Fluke 5502A or HP 3245A, monitored by HP 3458A |
| (10 to 100) mV                           | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz<br>(100 to 300) kHz<br>300 kHz to 1 MHz | $83 \mu V/V + 4.7 \mu V$ $83 \mu V/V + 2.4 \mu V$ $0.016 \% + 2.7 \mu V$ $0.035 \% + 2.4 \mu V$ $0.092 \% + 2.8 \mu V$ $0.35 \% + 12 \mu V$ $1.2 \% + 12 \mu V$  |  |
| 100 mV to 1 V                            | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz<br>(100 to 300) kHz<br>300 kHz to 1 MHz | 82 μV/V + 47 μV<br>82 μV/V + 24 μV<br>0.016 % + 26 μV<br>0.035 % + 24 μV<br>0.092 % + 28 μV<br>0.35 % + 120 μV<br>1.2 % + 120 μV   |  |

| Parameter/Range              | Frequency  | CMC <sup>2, 7</sup> (±)   | Comments   |
|------------------------------|--|---|--|
| AC Voltage – Generate (cont) |  |   |  |
| (1 to 10) V                  | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz<br>(100 to 300) kHz<br>300 kHz to 1 MHz | $83 \ \mu V/V + 0.47 \ mV \\ 82 \ \mu V/V + 0.24 \ mV \\ 0.016 \ \% + 0.26 \ mV \\ 0.035 \ \% + 0.24 \ mV \\ 0.092 \ \% + 0.28 \ mV \\ 0.35 \ \% + 1.2 \ mV \\ 1.2 \ \% + 1.2 \ mV$ | Fluke 5502A or HP<br>3245A, monitored by<br>HP 3458A |
| (10 to 20) V                 | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz<br>(100 to 300) kHz<br>300 kHz to 1 MHz | 0.023 % + 4.7 mV<br>0.023 % + 2.4 mV<br>0.023 % + 2.4 mV<br>0.004 % + 2.5 mV<br>0.14 % + 2.4 mV<br>0.46 % + 12 mV<br>1.7 % + 19 mV  |  |
| (20 to 100) V                | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz   | 0.023 % + 4.8 mV<br>0.023 % + 2.5 mV<br>0.021 % + 4.9 mV<br>0.036 % + 6.8 mV<br>0.12 % + 21 mV  |  |
| (100 to 330) V               | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz   | 0.046 % + 47 mV<br>0.046 % + 24 mV<br>0.07 % + 23 mV<br>0.14 % + 23 mV<br>0.35 % + 23 mV  |  |
| (330 to 1000) V              | (1 to 40) Hz<br>40 Hz to 1 kHz<br>(1 to 10) kHz  | 0 046 % + 49 mV<br>0.046 % + 26 mV<br>0.07 % + 23 mV  |  |

| Parameter/Range                              | Frequency  | CMC <sup>2, 7</sup> (±)  | Comments                                    |
|--|--|--|---|
| AC Current – Generate & Measure <sup>3</sup> |  |  |   |
| Up to 100 μA                                 | (10 to 20) Hz<br>(20 to 45) Hz<br>45 Hz to 5 kHz   | $\begin{array}{c} 0.42\ \% + 0.077\ \mu A \\ 0.17\ \% + 0.038\ \mu A \\ 0.069\ \% + 0.036\ \mu A \end{array}$  | HP 3458A with<br>Fluke 5502A                |
| 100 μA to 1 mA                               | (10 to 20) Hz<br>(20 to 45) Hz<br>(45 to 100) Hz<br>100 Hz to 5 kHz<br>(5 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz              | $\begin{array}{c} 0.46 \% + 0.25 \ \mu A \\ 0.17 \% + 0.27 \ \mu A \\ 0.069 \% + 0.24 \ \mu A \\ 0.035 \% + 0.24 \ \mu A \\ 0.07 \% + 0.24 \ \mu A \\ 0.47 \% + 0.47 \ \mu A \\ 0.64 \% + 1.8 \ \mu A \end{array}$ |   |
| (1 to 10) mA                                 | (10 Hz to 20) Hz<br>(20 Hz to 45) Hz<br>(45 Hz to 100) Hz<br>100 Hz to 5 kHz<br>(5 kHz to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz | $\begin{array}{c} 0.46 \% + 2.5 \ \mu A \\ 0.17 \% + 2.7 \ \mu A \\ 0.069 \% + 2.4 \ \mu A \\ 0.035 \% + 2.4 \ \mu A \\ 0.07 \% + 2.4 \ \mu A \\ 0.47 \% + 4.7 \ \mu A \\ 0.64 \% + 18 \ \mu A \end{array}$        |   |
| (10 to 100) mA                               | (10 to 20) Hz<br>(20 to 45) Hz<br>(45 to 100) Hz<br>100 Hz to 5 kHz<br>(5 to 20) kHz<br>(20 to 50) kHz<br>(50 to 100) kHz              | $\begin{array}{c} 0.46 \% + 25 \; \mu A \\ 0.17 \% + 27 \; \mu A \\ 0.069 \% + 24 \; \mu A \\ 0.035 \% + 24 \; \mu A \\ 0.07 \% + 24 \; \mu A \\ 0.47 \% + 47 \; \mu A \\ 0.64 \% + 0.18 \; m A \end{array}$       |   |
| 100 mA to 1 A                                | (10 to 20) Hz<br>(20 to 45) Hz<br>(45 to 100) Hz<br>100 Hz to 5 kHz<br>(5 to 20) kHz<br>(20 to 50) kHz                                 | 0.46 % + 0.25 mA<br>0.18 % + 0.28 mA<br>0.092 % + 0.24 mA<br>0.12 % + 0.24 mA<br>0.35 % + 0.24 mA<br>1.2 % + 0.47 mA   |   |
| (1 to 10) A                                  | (1 to 50) Hz<br>50 Hz to 1 kHz<br>(1 to 5) kHz   | 0.0093 % + 0.46 mA<br>0.012 % + 0.45 mA<br>0.067 % + 1.2 mA  | HP 3458A with Fluke 5502A and current shunt |
| (10 to 20) A                                 | (1 to 50) Hz<br>50 Hz to 1 kHz<br>(1 to 5) kHz   | 0.0083 % + 0.47 mA<br>0.012 % + 2.2 mA<br>0.066 % + 1.1 mA   |   |

| Parameter/Range                    | Frequency   | CMC <sup>2, 7</sup> (±)  | Comments    |
|------------------------------------|---|--|-------------|
| AC Current – Generate <sup>3</sup> |   |  |             |
| (29 to 330) μA                     | (10 to 20) Hz<br>(20 to 45) Hz<br>45 Hz to 1 kHz<br>(1 to 5) kHz<br>(5 to 10) kHz<br>(10 to 30) kHz | $\begin{array}{c} 0.23 \% + 0.13 \; \mu A \\ 0.17 \% + 0.13 \; \mu A \\ 0.14 \% + 0.14 \; \mu A \\ 0.35 \% + 0.18 \; \mu A \\ 0.92 \% + 0.25 \; \mu A \\ 1.8 \% + 0.62 \; \mu A \end{array}$ | Fluke 5502A |
| 330 μA to 3.3 mA                   | (10 to 20) Hz<br>(20 to 45) Hz<br>45 Hz to 1 kHz<br>(1 to 5) kHz<br>(5 to 10) kHz<br>(10 to 30) kHz | $\begin{array}{c} 0.23~\% + 0.23~\mu A \\ 0.14~\% + 0.32~\mu A \\ 0.12~\% + 0.18~\mu A \\ 0.23~\% + 0.27~\mu A \\ 0.58~\% + 0.35~\mu A \\ 1.2~\% + 0.7~\mu A \end{array}$                    |             |
| (3.3 to 33) mA                     | (10 to 20) Hz<br>(20 to 45) Hz<br>45 Hz to 1 kHz<br>(1 to 5) kHz<br>(5 to 10) kHz<br>(10 to 30) kHz | $\begin{array}{c} 0.21 \% + 2.4 \ \mu A \\ 0.1 \% + 3.8 \ \mu A \\ 0.047 \% + 2.4 \ \mu A \\ 0.093 \% + 2.4 \ \mu A \\ 0.23 \% + 3.8 \ \mu A \\ 0.46 \% + 5.3 \ \mu A \end{array}$           |             |
| (33 to 330) mA                     | (10 to 20) Hz<br>(20 to 45) Hz<br>45 Hz to 1 kHz<br>(1 to 5) kHz<br>(5 to 10) kHz<br>(10 to 30) kHz | 0.21 % + 23 μA<br>0.1 % + 38 μA<br>0.047 % + 24 μA<br>0.12 % + 58 μA<br>0.23 % + 0.12 mA<br>0.46 % + 0.24 mA   |             |
| 330 mA to 1.1 A                    | (10 to 45) Hz<br>45 Hz to 1 kHz<br>(1 to 5) kHz<br>(5 to 10) kHz                                    | 0.21 % + 0.12 mA<br>0.058 % + 0.12 mA<br>0.69 % + 1.2 mA<br>2.9 % + 5.8 mA   |             |
| (1.1 to 3) A                       | (10 to 45) Hz<br>45 Hz to 1 kHz<br>(1 to 5) kHz<br>(5 to 10) kHz                                    | 0.21 % + 0.12 mA<br>0.069 % + 0.13 mA<br>0.69 % + 1.3 mA<br>2.9 % + 5.8 mA   |             |
| (3 to 11) A                        | (45 to 100) Hz<br>100 Hz to 1 kHz<br>(1 to 5) kHz   | 0.069 % + 2.4 mA<br>0.12 % + 2.4 mA<br>3.5 % + 2.4 mA  |             |

| Parameter/Range                           | Frequency  | CMC <sup>2, 7</sup> (±)  | Comments                      |
|---|--|--|-------------------------------|
| AC Current – Generate <sup>3</sup> (cont) |  |  |                               |
| (11 to 20.5) A                            | (45 to 100) Hz<br>100 Hz to 1 kHz<br>(1 to 5) kHz                | 0.14 % + 5.8 mA<br>0.17 % + 6.5 mA<br>3.5 % + 5.8 mA                   | Fluke 5502A                   |
| (11 to 30) A                              | (10 to 45) Hz<br>45 Hz to 1 kHz<br>(1 to 5) kHz<br>(5 to 10) kHz | 0.29 % + 0.87 mA<br>0.21 % + 0.9 mA<br>0.72 % + 12 mA<br>2.9 % + 58 mA | Fluke 5502A with 10 turn coil |
| (30 to 110) A                             | (45 to 100) Hz<br>100 Hz to 1 kHz<br>(1 to 5) kHz                | 0.21 % + 12 mA<br>0.23 % + 15 mA<br>3.5 % + 24 mA                      |                               |
| (110 to 205) A                            | (45 to 100) Hz<br>100 Hz to 1 kHz<br>(1 to 5) kHz                | 0.24 % + 42 mA<br>0.26 % + 49 mA<br>3.5 % + 58 mA                      |                               |
| (60 to 220) A                             | 45 to 100) Hz<br>100 Hz to 1 kHz<br>(1 to 5) kHz                 | 0.21 % + 24 mA<br>0.23 % + 30 mA<br>3.5 % + 47 mA                      | Fluke 5502A with 20 turn coil |
| (220 to 410) A                            | (45 to 100) Hz<br>100 Hz to 1 kHz<br>(1 to 5) kHz                | 0.24 % + 84 mA<br>0.26 % + 98 mA<br>3.5 % + 0.12 A                     |                               |
| (150 to 550) A                            | (45 to 100) Hz<br>100 Hz to 1 kHz<br>(1 to 5) kHz                | 0.21 % + 59 mA<br>0.23 % + 74 mA<br>3.5 % + 0.12 A                     | Fluke 5502A with 50 turn coil |
| (550 to 1025) A                           | (45 to 100) Hz<br>100 Hz to 1 kHz<br>(1 to 5) kHz                | 0.24 % + 0.21 A<br>0.26 % + 0.25 A<br>3.5 % + 0.29 A                   |                               |

| Parameter/Equipment                                     | Range  | CMC <sup>2, 7</sup> (±)  | Comments                      |
|---|--|--|-------------------------------|
| DC Power – Generate <sup>3</sup>                        | Up to 109 μW<br>(0.109 to 1.09) mW<br>(1.09 to 10.9) mW<br>(10.9 to 109) mW<br>(0.109 to 1.09) W<br>(1.09 to 10.9) W<br>(10.9 to 109) W<br>(109 to 330) W<br>(0.33 to 3) kW<br>(3 to 11) kW<br>(11 to 20.5) kW   | 0.36 % rdg<br>0.035 % rdg<br>0.024 % rdg<br>0.019 % rdg<br>0.023 % rdg<br>0.023 % rdg<br>0.023 % rdg<br>0.015 % rdg<br>0.06 % rdg<br>0.092 % rdg<br>0.14 % rdg                     | Fluke 5502A                   |
|   | (3.3 to 30) kW<br>(30 to 110) kW<br>(110 to 205) kW  | 0.21 % rdg<br>0.22 % rdg<br>0.24 % rdg   | Fluke 5502A with 10 turn coil |
|   | (60 to 220) kW<br>(220 to 410) kW  | 0.22 % rdg<br>0.24 % rdg   | Fluke 5502A with 20 turn coil |
|   | (150 to 550) kW<br>(550 to 1025) kW  | 0.22 % rdg<br>0.24 % rdg   | Fluke 5502A with 50turn coil  |
| AC Power – Generate<br>(45 to 65 Hz, PF=1) <sup>3</sup> | Up to 10.9 μW<br>(10.9 to 109) μW<br>(0.109 to 1.09) mW<br>(1.09 to 10.9) mW<br>(10.9 to 10.9) W<br>(1.09 to 10.9) W<br>(1.09 to 10.9) W<br>(10.9 to 10.9) W<br>(10.9 to 363) W<br>(363 to 990) W<br>(0.99 to 3.63) kW<br>(3.63 to 11.2) kW<br>(11.2 to 20.9) kW | 2.5 % rdg<br>0.26 % rdg<br>0.17 % rdg<br>0.13 % rdg<br>0.078 % rdg<br>0.078 % rdg<br>0.13 % rdg<br>0.12 % rdg<br>0.12 % rdg<br>0.10 % rdg<br>0.21 % rdg<br>0.16 % rdg<br>0.21% rdg | Fluke 5502A                   |
|   | (9.9 to 36.3) kW<br>(30 to 110) kW<br>(110 to 205) kW  | 0.26% rdg<br>0.26% rdg<br>0.29% rdg  | Fluke 5502A with 10 turn coil |
|   | (60 to 220.) kW<br>(220 to 410) kW   | 0.26% rdg<br>0.29% rdg   | Fluke 5502A with 20 turn coil |
|   | (150 to 550) kW<br>(550 to 1025) kW  | 0.25% rdg<br>0.29% rdg   | Fluke 5502A with 50turn coil  |

| Parameter/Equipment   | Range   | CMC <sup>2, 7</sup> (±)   | Comments   |
|---|---|---|--|
| Electrical Calibration of<br>Phase Indicators –<br>Source Only <sup>3</sup> | (10 to 65) Hz<br>(65 to 500) Hz<br>500 Hz to 1 kHz<br>(1 to 5) kHz<br>(5 to 10) kHz<br>(10 to 30) kHz | 0.19° phase<br>1.1° phase<br>2.4° phase<br>7.0° phase<br>12° phase<br>18° phase | Fluke 5502A  |
| Electrical Conductivity –<br>Secondary Standards                            | Up to 13 % IACS<br>(13 to 62) % IACS<br>> 62 % IACS   | 0.07 % IACS<br>0.35 % rdg + 0.05 % IACS<br>0.3 % rdg + 0.05 % IACS              | ASTM E1004<br>electrical conductivity<br>by eddy current |
| Electrical Conductivity –<br>Working Standards                              | Up to 13 % IACS<br>(13 to 62) % IACS<br>> 62 % IACS   | 0.12 % IACS<br>0.4 % rdg + 0.07 % IACS<br>0.35 % rdg + 0.11 % IACS              | ASTM E1004<br>electrical conductivity<br>by eddy current |
| Electrical Conductivity –<br>Measuring Equipment                            | Up to 16 % IACS<br>(16 to 62) % IACS<br>> 62 % IACS   | 0.13 % IACS<br>0.4 % rdg + 0.07 % IACS<br>0.42 % rdg + 0.05 % IACS              | ASTM E1004<br>electrical conductivity<br>by eddy current |

#### IV. Mechanical

| Parameter/Equipment              | Range   | CMC <sup>2, 5</sup> (±)  | Comments  |
|----------------------------------|---|--|---|
| Torque Wrenches <sup>3</sup>     | (0.5 to 15) ozf·in  | 0.082 % setting + 0.017<br>ozf·in  | Torque arm and deadweights  |
|                                  | 15 ozf·in to 2000 lbf·ft  | 0.66 % setting   | Torque transducers  |
| Torque Transducers               | (1.25 to 40) ozf·in<br>(2.5 to 100) lbf·in<br>(8.3 to 50) lbf·ft<br>(50 to 150) lbf·ft<br>(150 to 1200) lbf·ft                    | 0.17 % rdg + 0.0003 ozf·in<br>0.12 % rdg<br>0.11 % rdg<br>0.10 % rdg<br>0.11 % rdg   | Torque wheel/arms and weights   |
| Scales and Balances <sup>3</sup> | (0.5 to 380) g<br>(380 to 1800) g<br>(0 to 200) g<br>(200 to 1000) g<br>(1 to 16.2) kg<br>(0.1 to 700) lb,<br>((0.045 to 318) kg) | (0.037 + 0.000 23 <i>W</i> ) mg<br>(0.12 + 0.0001 <i>W</i> ) mg<br>(0.69 + 0.0094 <i>W</i> ) mg<br>(0.51 + 0.012 <i>W</i> ) mg<br>(26 + 0.0048 <i>W</i> ) mg<br>(260 + 3.5 <i>W</i> ) mg | Ultra Class weights, Class 1 weights  Class F and 6 weights  (This instance, "W" = weight in lbs) |



| Parameter/Equipment   | Range                           | CMC <sup>2</sup> (±)                      | Comments                           |
|---|---------------------------------|---|------------------------------------|
| Indirect Verification of<br>Rockwell<br>Hardness Testers <sup>3</sup> | HRA<br>Low<br>Medium<br>High    | 0.31 HRA<br>0.32 HRA<br>0.20 HRA          | Indirect verification per ASTM E18 |
|   | HRBW<br>Low<br>Medium<br>High   | 0.36 HRBW<br>0.26 HRBW<br>0.39 HRBW       |                                    |
|   | HRC<br>Low<br>Medium<br>High    | 0.39 HRC<br>0.33 HRC<br>0.32 HRC          |                                    |
|   | HREW<br>Low<br>Medium<br>High   | 0.38 HREW<br>0.49 HREW<br>0.49 HREW       |                                    |
|   | HRFW<br>Low<br>Medium<br>High   | 0.28 HRFW<br>0.46 HRFW<br>0.45 HRFW       |                                    |
|   | HRHW<br>Low<br>High             | 0.42 HRHW<br>0.36 HRHW                    |                                    |
|   | HR15N<br>Low<br>Medium<br>High  | 0.42 HR15N<br>0.42 HR15N<br>0.51 HR15N    |                                    |
|   | HR30N<br>Low<br>Medium<br>High  | 0.30 HR30N<br>0.47 HR30N<br>0.53 HR30N    |                                    |
|   | HR45N<br>Low<br>Medium<br>High  | 0.50 HR45N<br>0.25 HR45N<br>0.20 HR45N    |                                    |
|   | HR15TW<br>Low<br>Medium<br>High | 0.44 HR15TW<br>0.39 HR15TW<br>0.32 HR15TW |                                    |

| Parameter/Equipment   | Range  | CMC <sup>2, 5</sup> (±)                          | Comments   |
|---|--|--|--|
| Indirect Verification of<br>Rockwell Hardness<br>Testers <sup>3</sup> (cont)                | HR30TW<br>Low<br>Medium<br>High                      | 0.58 HR30TW<br>0.64 HR30TW<br>0.22 HR30TW        | Indirect verification per ASTM E18   |
|   | HR45TW<br>Low<br>Medium<br>High                      | 0.70 HR45TW<br>0.40 HR45TW<br>0.39 HR45TW        |  |
| Direct Verification of<br>Rockwell Hardness<br>Testers <sup>3</sup> –                       |  |  | ASTM E18   |
| Verification of Test<br>Force   | (3 to 15) kgf<br>(30 to 150) kgf                     | 0.005 kgf + 0.03 % rdg<br>0.049 kgf + 0.02 % rdg | Verification of test force by load cell                                      |
| Verification of<br>Depth-Measuring<br>Device  | (0 to 260) μm  | 0.31 μm  | Per direct verification<br>method of ASTM E18                                |
| Verification of<br>Hysteresis   |  | 0.25 Rockwell Points                             | Per direct verification<br>method of ASTM E18                                |
| Indirect Verification of<br>Brinell Hardness Testers<br>at Test Condition(s) <sup>3</sup> – |  |  | ATSM E10  D is the mean of the n mean test diameters in                      |
| 10/3000/15  | Repeatability:  < 225 HBW (> 225 to 650) HBW  Error: | 0.024 <i>D</i><br>0.013 <i>D</i><br>1.5 %        | millimeters  Error uncertainty is stated as a percentage of the standardized |
| 40/2004   |  | 1.5 /0   | test block value   |
| 10/500/15   | Repeatability: (40 to 126) HBW                       | 0.024 <i>D</i>                                   |  |
|   | Error:   | 1.9 %  |  |

| Parameter/Equipment  | Range   | CMC <sup>2, 9</sup> (±)    | Comments          |
|--|---|----------------------------|-------------------|
| Indirect Verification of<br>Microindentation<br>Hardness Testers <sup>3</sup><br>(Knoop and Vickers) | Vickers:<br>< 240 HV<br>(240 to 600) HV<br>> 600 HV | 4.3 HV<br>10 HV<br>13 HV   | ASTM E384 and E92 |
|  | Knoop:<br>< 250 HK<br>(250 to 650) HK<br>> 650 HK   | 5.2 HK<br>12 HK<br>15 HK   |                   |
| Pressure <sup>3</sup> -  |   |                            |                   |
| Absolute &<br>Barometric Pressure  | (0 to 35) in·Hg                                     | 0.0034 in·Hg               | Mensor CPG system |
| Differential & Gage<br>Pressure  | (0 to 30) in·H <sub>2</sub> O                       | 0.0029 in·H <sub>2</sub> O |                   |
| Tressure   | (0 to 5) psi  | 0.000 47 psi               |                   |
|  | (5 to 15) psi                                       | 0.0015 psi                 |                   |
|  | (10 to 500) psi                                     | 0.002 psi + 0.018 % rdg    | Deadweight tester |
|  | (200 to 10 000) psi                                 | 0.034 psi + 0.018 % rdg    |                   |
| Vacuum <sup>3</sup> – Measure<br>and Measuring<br>Equipment  | (0 to 28.5) in·Hg                                   | 0.0033 in·Hg               | Mensor CPG system |

# V. Thermodynamics

| Parameter/Equipment       | Range  | CMC <sup>2</sup> (±)                         | Comments         |
|---------------------------|--|--|------------------|
| Thermometers <sup>3</sup> | (-112 °F to 32) °F<br>(32 °F to 212) °F<br>(212 °F to 392) °F<br>(392 to 752) °F | 0.048 °F<br>0.041 °F<br>0.047 °F<br>0.098 °F | PRT, Fluke 1502A |

| Parameter/Equipment | Range   | $CMC^{2}(\pm)$                                   | Comments  |
|---------------------|---|--|---|
| Thermocouples –     |   |  |   |
| Туре Е              | (-112 to -22) °F<br>(-22 to 752) °F<br>(752 to 1200) °F<br>(1200 to 1832) °F                      | 0.19 °F<br>0.18 °F<br>2.0 °F<br>2.2 °F           | Type "S" platinum<br>standard T/C above<br>752 °F, PRT below<br>752 °F, Fluke 1502A,<br>Fluke 8846A |
| Type J              | (-112 to -22) °F<br>(-22 to 752) °F<br>(752 to 1200) °F<br>(1200 to 2000) °F<br>(2000 to 2192) °F | 0.20 °F<br>0.21 °F<br>1.5 °F<br>2.0 °F<br>2.7 °F |   |
| Туре К              | (-112 to -22) °F<br>(-22 to 752) °F<br>(752 to 1200) °F<br>(1200 to 2000) °F<br>(2000 to 2500) °F | 0.22 °F<br>0.24 °F<br>1.5 °F<br>2.0 °F<br>3.2 °F |   |
| Type N              | (-112 to -22) °F<br>(-22 to 752) °F<br>(752 to 1200) °F<br>(1200 to 2000) °F<br>(2000 to 2372) °F | 0.28 °F<br>0.26 °F<br>1.6 °F<br>2.1 °F<br>2.9 °F |   |
| Type R              | (32 to 752) °F<br>(752 to 1200) °F<br>(1200 to 2000) °F<br>(2000 to 2500) °F                      | 0.81 °F<br>1.6 °F<br>2.0 °F<br>3.3 °F            |   |
| Type S              | (32 to 752) °F<br>(752 to 1200) °F<br>(1200 to 2000) °F<br>(2000 to 2500) °F                      | 0.81 °F<br>1.6 °F<br>2.0 °F<br>3.2 °F            |   |
| Туре Т              | (-112 to -22) °F<br>(-22 to 752) °F   | 0.23 °F<br>0.20 °F                               |   |
| Type R              | (32 to 752) °F<br>(752 to 1200) °F<br>(1200 to 2000) °F<br>(2000 to 2500) °F                      | 0.81 °F<br>1.0 °F<br>1.2 °F<br>3.2 °F            | Above 752 °F,<br>comparison with NIST<br>ref. standard<br>below 752 °F, PRT,<br>Fluke 1502A, Fluke  |
| Type S              | (32 to 752) °F<br>(752 to 1200) °F<br>(1200 to 2000) °F<br>(2000 to 2500) °F                      | 0.81 °F<br>1.0 °F<br>1.2 °F<br>3.2 °F            | 8846A   |

| Parameter/Equipment  | Range   | CMC <sup>2, 9</sup> (±)                          | Comments  |
|--|---|--|---|
| Temperature Uniformity<br>Survey <sup>3, 4</sup><br>(Per AMS 2750) | (-100 to 392) °F<br>(392 to 752) °F<br>(752 to 1200) °F<br>(1200 to 1800) °F<br>(1800 to 2300) °F | 1.4 °F<br>3.1 °F<br>3.1 °F<br>3.7 °F<br>4.1 °F   | IoTech DaqBook, with<br>expendable and non-<br>expendable<br>thermocouples    |
| Temperature Probe <sup>3, 4</sup> ("SAT" per AMS 2750)             | (-112 to 392) °F<br>(392 to 752) °F<br>(752 to 1200) °F<br>(1200 to 2000) °F<br>(1800 to 2372) °F | 0.64 °F<br>0.76 °F<br>1.8 °F<br>2.4 °F<br>3.2 °F | Fluke 726 or<br>equivalent, expendable<br>and non-expendable<br>thermocouples |
| Infrared Thermometers <sup>3</sup>                                 | (95 to 212) °F<br>(212 to 392) °F<br>(392 to 662) °F<br>(662 to 932) °F                           | 1.2 °F<br>1.6 °F<br>2.7 °F<br>3.7 °F             | Hart 4181 black body<br>Emissivity- 0.95                                      |
| Relative Humidity <sup>3</sup> – Measuring Equipment               | (10 to 95) % RH   | 0.85 % RH  | EdgeTech chilled mirror hygrometer  |
| Dewpoint <sup>3</sup> – Measuring Equipment                        | (-20 to 65) °C  | 0.14 °C  | EdgeTech chilled mirror hygrometer  |

### VI. Time & Frequency

| Parameter/Equipment | Range                           | CMC <sup>2, 9</sup> (±)   | Comments |
|---------------------|---------------------------------|---------------------------|----------|
| Frequency – Measure | (1 to 40) Hz<br>40 Hz to 10 MHz | 0.06 % rdg<br>0.012 % rdg | HP3458A  |

| Parameter/Equipment                             | Range  | CMC <sup>2, 9</sup> (±)   | Comments            |
|---|--|---|---------------------|
| Frequency – Measuring<br>Equipment <sup>3</sup> | Up to 120 Hz<br>(0.12 to 1.2) kHz<br>(1.2 to 12) kHz<br>(12 to 120) kHz<br>(0.12 to 1.2) MHz<br>(1.2 to 2) MHz | 28 μHz/Hz + 0.0016 Hz<br>25 μHz/Hz + 0.0077 Hz<br>25 μHz/Hz + 0.071 Hz<br>29 μHz/Hz + 18 Hz<br>29 μHz/Hz + 20 Hz<br>0.020 % rdg | Fluke 5502A         |
| Timers, Stopwatches <sup>3</sup>                | 15 s to 10 min   | 0.038 s + 0.0025 % of timed interval  | Reference stopwatch |
|   | 10 min to 24 hrs   | 0.038 s + 0.0041 % of timed interval  |                     |
|   | (2 to 24) hrs  | 0.038 s   | WWV signal          |

<sup>&</sup>lt;sup>1</sup> This laboratory offers commercial dimensional testing, calibration, and field calibration service.

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<sup>&</sup>lt;sup>2</sup> Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of k = 2. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

<sup>&</sup>lt;sup>3</sup> Field calibration service is available for this calibration. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the actual uncertainty introduced by the item being calibrated, (e.g. resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

<sup>&</sup>lt;sup>4</sup> The CMC is stated for calibrations performed in the field only.

<sup>&</sup>lt;sup>5</sup> In the statement of the CMC, *L* is the numerical value of the nominal length of the device measured in inches. In the statement of best uncertainty, *D* is the numerical value of the nominal diameter of the device measured in inches; *W* is numerical value of the nominal applied mass in grams; and, *R* is the resolution of the device under test.

<sup>&</sup>lt;sup>6</sup> This laboratory meets *R205 – Specific Requirements: Calibration Laboratory Accreditation Program* for the types of dimensional tests listed above and is considered equivalent to that of a calibration.

- <sup>7</sup> The stated measured values are determined using the indicated instrument (see Comments). This capability is suitable for the calibration of the devices intended to measure or generate the measured value in the ranges indicated. CMC are expressed as either a specific value that covers the full range or as a fraction or percentage of the reading plus a fixed floor specification.
- <sup>8</sup> This scope meets A2LA's *P112 Flexible Scope Policy*.
- <sup>9</sup> The type of instrument or material being calibrated is defined by the parameter. This indicates the laboratory is capable of calibrating instruments that measure or generate the values in the ranges indicated for the listed measurement parameter.

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# **Accredited Laboratory**

A2LA has accredited

# JOHNSON GAGE AND INSPECTION

Wichita, KS

for technical competence in the field of

## Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 General requirements for the competence of testing and calibration laboratories. This laboratory also meets the requirements of ANSI/NCSL Z540-1-1994 and R205 – Specific Requirements: Calibration Laboratory Accreditation Program. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).

SEAL 1978 SEAL 1978 A2LA 101.

Presented this 27th day of March 2023.

Mr. Trace McIntruff, Vice President, Accreditation Services

For the Accreditation Council Certificate Number 2820.01

Valid to March 31, 2025

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.